

Notice of References Cited	Application/Control No. 10/630,746	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner William P. Watkins III	Art Unit 1772	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-4,920,639	05-1990	Yee, Ian Y. K.	29/846
*	C	US-6,509,880	01-2003	Sabet et al.	343/770
*	D	US-5,073,814	12-1991	Cole et al.	257/643
*	E	US-5,858,145	01-1999	Sreeram et al.	156/89.16
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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